



**ALPHA & OMEGA**  
SEMICONDUCTOR

# AOT66920L/AOB66920L

100V N-Channel AlphaSGT™

## General Description

- Trench Power MOSFET - AlphaSGT™ technology
- Low  $R_{DS(ON)}$
- Logic Level Driving
- Excellent  $Q_G \times R_{DS(ON)}$  Product (FOM)
- RoHS and Halogen-Free Compliant

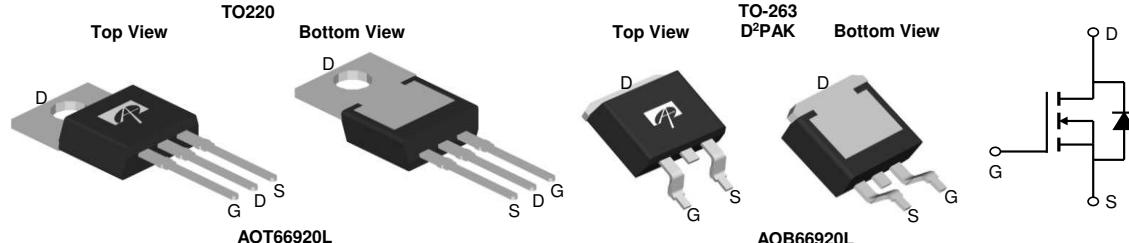
## Product Summary

|                                  |          |
|----------------------------------|----------|
| $V_{DS}$                         | 100V     |
| $I_D$ (at $V_{GS}=10V$ )         | 80A      |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 8mΩ    |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 10.5mΩ |

## Applications

- High Frequency Switching and Synchronous Rectification

100% UIS Tested  
100%  $R_g$  Tested



| Orderable Part Number | Package Type | Form        | Minimum Order Quantity |
|-----------------------|--------------|-------------|------------------------|
| AOT66920L             | TO-220       | Tube        | 1000                   |
| AOB66920L             | TO-263       | Tape & Reel | 800                    |

## Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                              | Symbol         | Maximum    | Units |
|--|----------------|------------|-------|
| Drain-Source Voltage                   | $V_{DS}$       | 100        | V     |
| Gate-Source Voltage                    | $V_{GS}$       | $\pm 20$   | V     |
| Continuous Drain Current <sup>A</sup>  | $I_D$          | 80         | A     |
| $T_C=100^\circ C$                      |                | 50         |       |
| Pulsed Drain Current <sup>C</sup>      | $I_{DM}$       | 180        |       |
| Continuous Drain Current <sup>A</sup>  | $I_{DSM}$      | 22.5       | A     |
| $T_A=70^\circ C$                       |                | 18         |       |
| Avalanche Current <sup>C</sup>         | $I_{AS}$       | 38         | A     |
| Avalanche energy <sup>C</sup>          | $E_{AS}$       | 72         | mJ    |
| Power Dissipation <sup>B</sup>         | $P_D$          | 100        | W     |
| $T_C=100^\circ C$                      |                | 40         |       |
| Power Dissipation <sup>A</sup>         | $P_{DSM}$      | 8.3        | W     |
| $T_A=70^\circ C$                       |                | 5.3        |       |
| Junction and Storage Temperature Range | $T_J, T_{STG}$ | -55 to 150 | °C    |

## Thermal Characteristics

| Parameter                                | Symbol    | Typ | Max  | Units |
|--|-----------|-----|------|-------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{QJA}$ | 12  | 15   | °C/W  |
| Maximum Junction-to-Ambient <sup>D</sup> |           | 50  | 60   | °C/W  |
| Maximum Junction-to-Case                 | $R_{QJC}$ | 1.0 | 1.25 | °C/W  |

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions  | Min  | Typ  | Max       | Units            |
|-----------------------------|---------------------------------------|---|------|------|-----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |   |      |      |           |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$  | 100  |      |           | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=100\text{V}, V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$              |      |      | 1<br>5    | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$                                     |      |      | $\pm 100$ | nA               |
| $V_{GS(\text{th})}$         | Gate Threshold Voltage                | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$   | 1.5  | 2.0  | 2.5       | V                |
| $R_{DS(\text{ON})}$         | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}, I_D=20\text{A}$   |      | 6.5  | 8.0       | $\text{m}\Omega$ |
|                             |                                       | $T_J=125^\circ\text{C}$   | 11.3 | 13.8 |           |                  |
|                             |                                       | $V_{GS}=4.5\text{V}, I_D=20\text{A}$  |      | 8.3  | 10.5      |                  |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}, I_D=20\text{A}$  |      | 65   |           | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}, V_{GS}=0\text{V}$   |      | 0.7  | 1         | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |   |      |      | 80        | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |      |      |           |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}, V_{DS}=50\text{V}, f=1\text{MHz}$                          |      | 2500 |           | pF               |
| $C_{oss}$                   | Output Capacitance                    |   |      | 485  |           | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |   |      | 13   |           | pF               |
| $R_g$                       | Gate resistance                       | $f=1\text{MHz}$   | 0.5  | 1.1  | 1.8       | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |   |      |      |           |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}, V_{DS}=50\text{V}, I_D=20\text{A}$                        |      | 35   | 50        | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |   |      | 16.7 | 25        | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |   |      | 8    |           | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |   |      | 5    |           | nC               |
| $Q_{oss}$                   | Output Charge                         | $V_{GS}=0\text{V}, V_{DS}=50\text{V}$   |      | 44   |           | nC               |
| $t_{D(\text{on})}$          | Turn-On Delay Time                    | $V_{GS}=10\text{V}, V_{DS}=50\text{V}, R_L=2.5\Omega, R_{\text{GEN}}=3\Omega$ |      | 10   |           | ns               |
| $t_r$                       | Turn-On Rise Time                     |   |      | 4    |           | ns               |
| $t_{D(\text{off})}$         | Turn-Off Delay Time                   |   |      | 31   |           | ns               |
| $t_f$                       | Turn-Off Fall Time                    |   |      | 6    |           | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$                               |      | 34   |           | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$                               |      | 170  |           | nC               |

A. The value of  $R_{\text{JJA}}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\text{JJA}} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ .

D. The  $R_{\text{JJA}}$  is the sum of the thermal impedance from junction to case  $R_{\text{JJC}}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 $\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .

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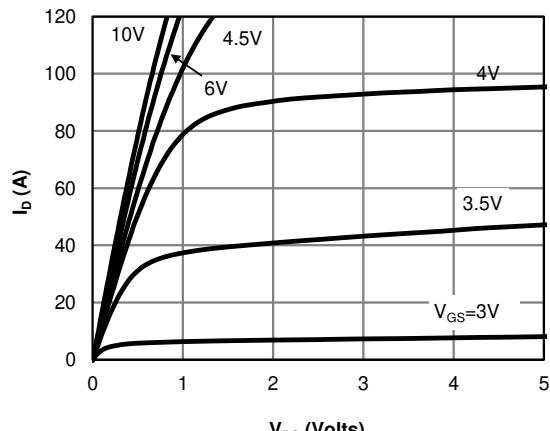
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


Figure 1: On-Region Characteristics (Note E)

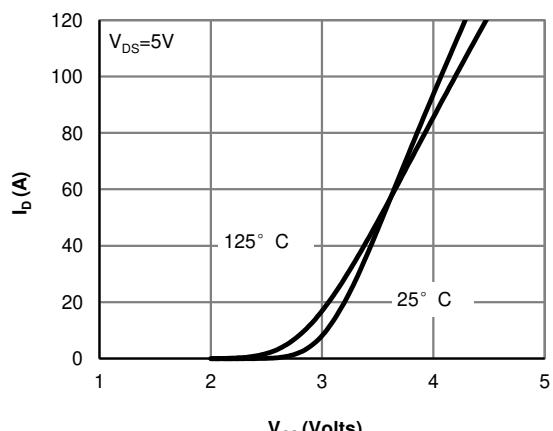


Figure 2: Transfer Characteristics (Note E)

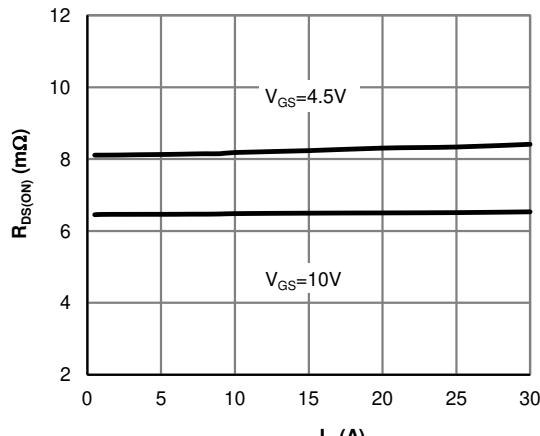


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

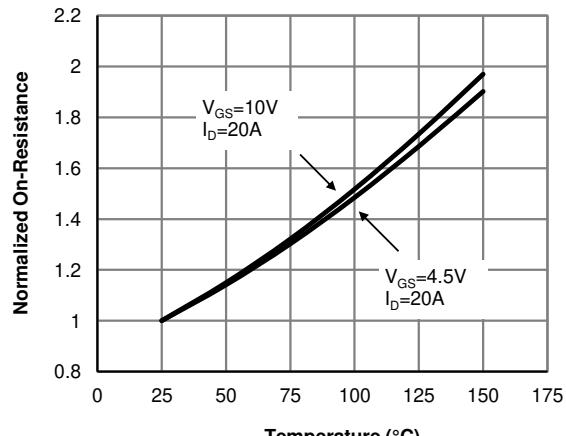


Figure 4: On-Resistance vs. Junction Temperature (Note E)

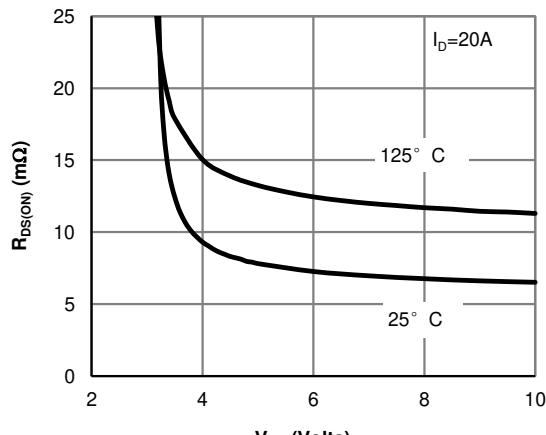


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

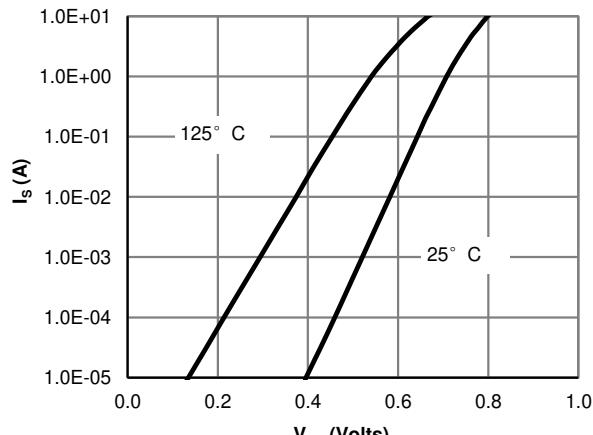
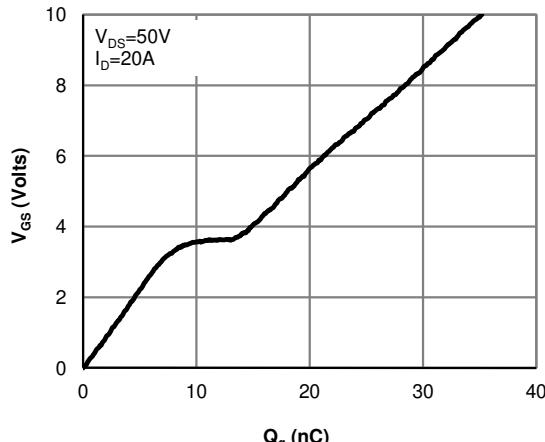
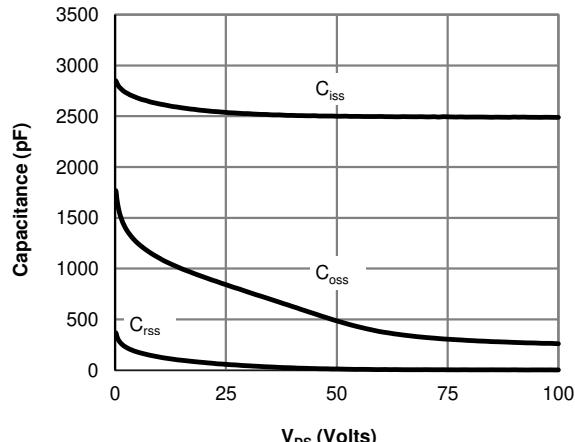
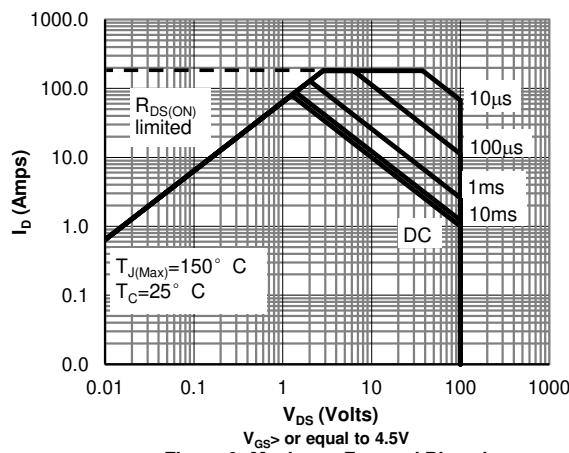
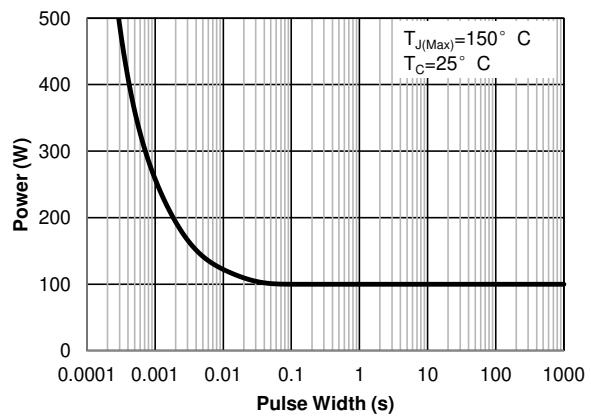
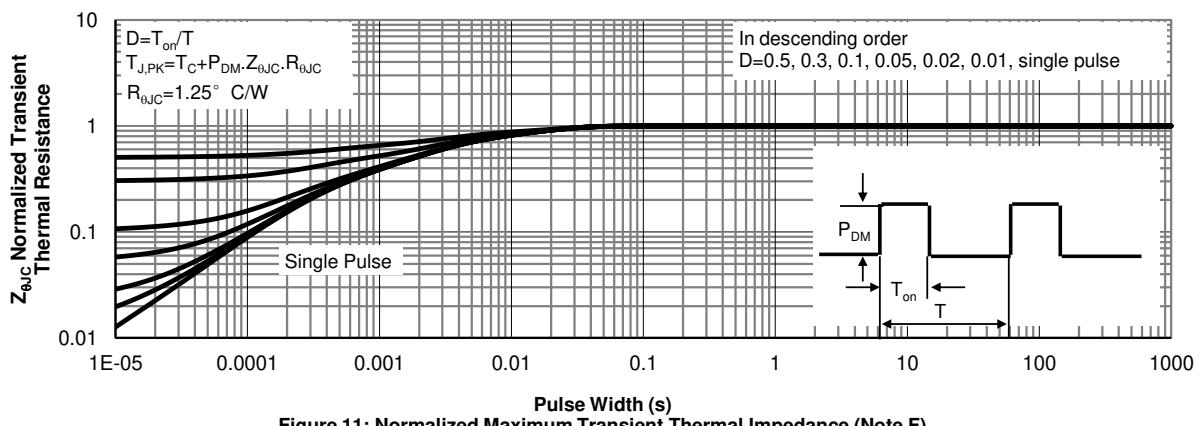


Figure 6: Body-Diode Characteristics (Note E)

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 7: Gate-Charge Characteristics**

**Figure 8: Capacitance Characteristics**

**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**

**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

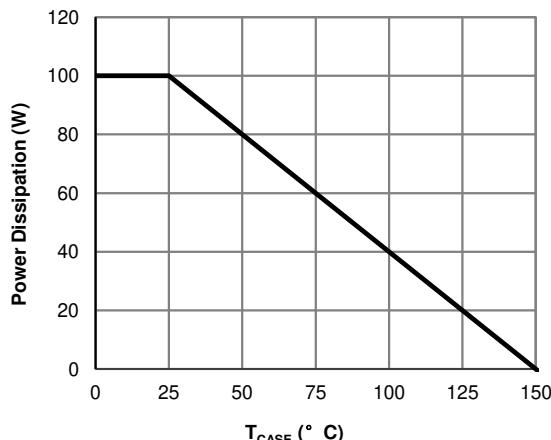
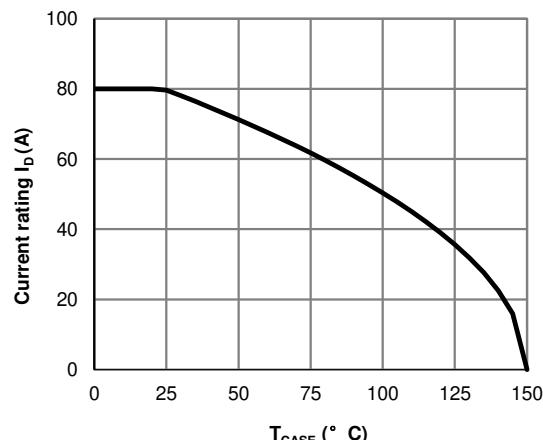
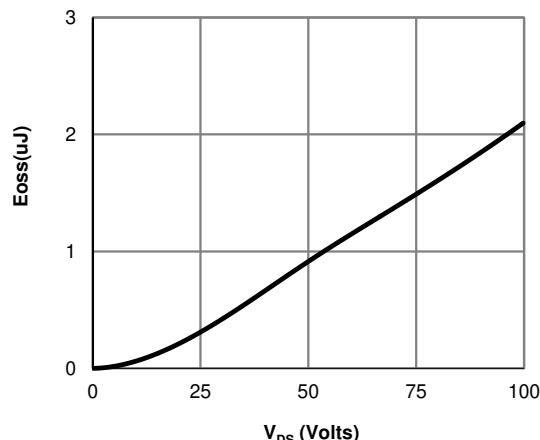
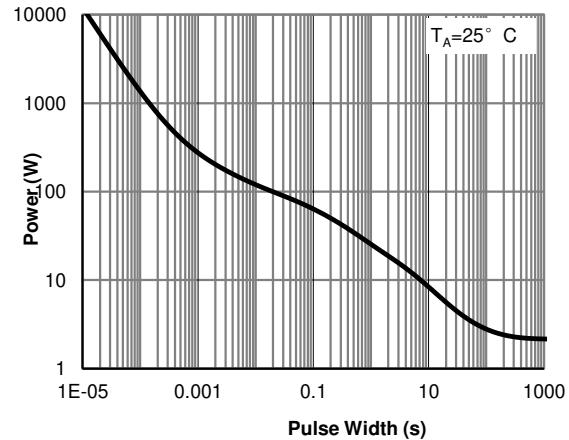
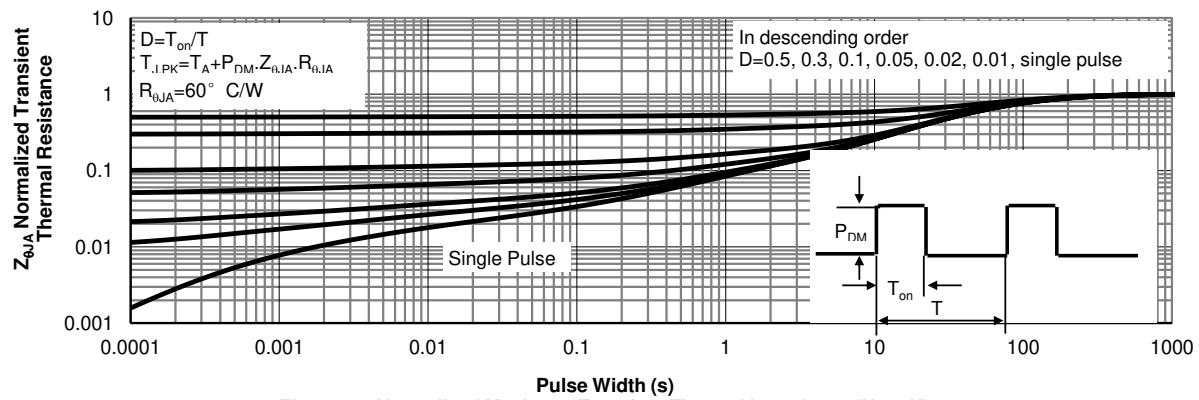
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 12: Power De-rating (Note F)**

**Figure 13: Current De-rating (Note F)**

**Figure 14: Coss stored Energy**

**Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)**

**Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)**

Figure A: Gate Charge Test Circuit &amp; Waveforms

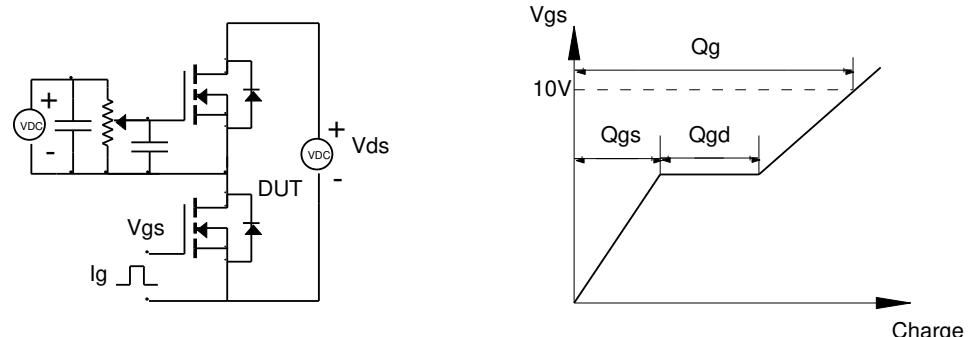


Figure B: Resistive Switching Test Circuit &amp; Waveforms

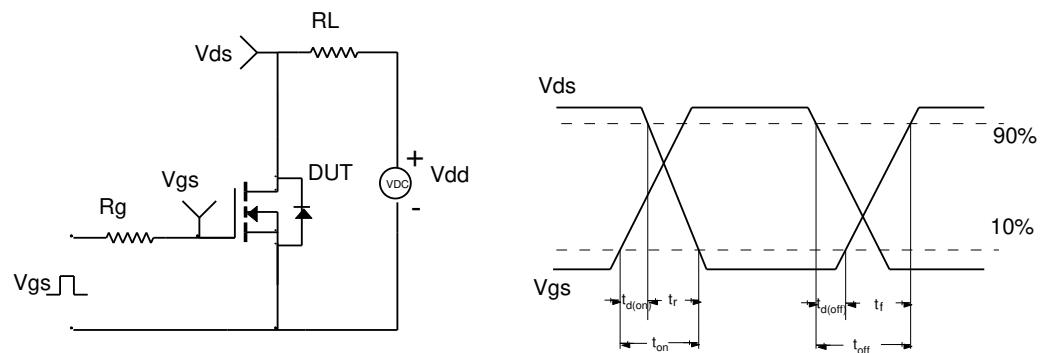


Figure C: Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms

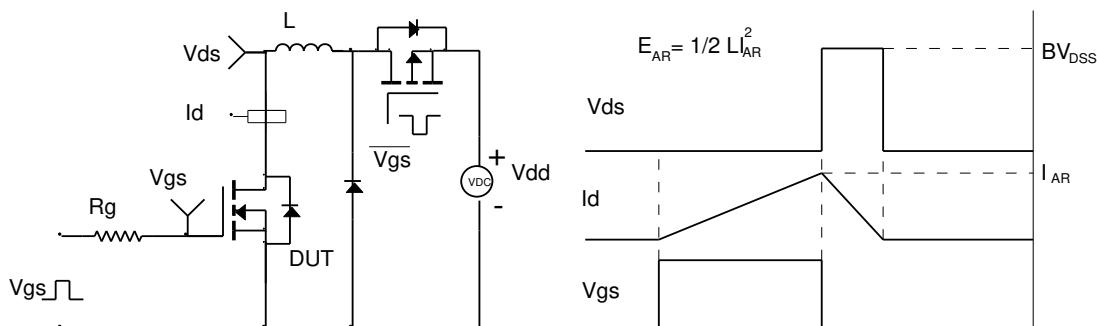


Figure D: Diode Recovery Test Circuit &amp; Waveforms

